

Notice of References Cited	Application/Control No. 09/746,489	Applicant(s)/Patent Under Reexamination TEICH ET AL.	
	Examiner Todd M Jack	Art Unit 2132	Page 1 of 1

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	C	US-6,003,134	12-1999	Kuo et al.	713/200
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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